Application/Control No. Applicant(s)/Patent Under Reexamination 10/670,269 HSIEH, YOU-JUN Notice of References Cited Art Unit Examiner Page 1 of 1 Jean E. Lesperance 2629 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY * US-6,525,743 B1 02-2003 Patrick et al. Α 345/619 US-В US-С US-D US-Ε US-F US-G US-Н US-US-J US-Κ US-L US-M **FOREIGN PATENT DOCUMENTS** Date Document Number Country Country Code-Number-Kind Code Name Classification MM-YYYY Ν 0 Ρ Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U V w

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